

Application/Control	No
10/561,965	

Examiner Hien N. Nguyen Applicant(s)/Patent under Reexamination TOKITO, SHUNSAKU

Art Unit 2824

				ISSUE	CL	<u>.AS</u>	SIF	ICAII	<u>ON</u>					
		ORIGINAL						INTE	ERNATIONAL	CLASSIFICATION				
CLASS SUBCLASS							CI	.AIMED		NON-CLAIMED				
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	Claims renumbered in the same order as presented by applicant						cant	□СРА			☐ T.D.			☐ R.1.47					
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original	!	Final	Original		Final	Original
1	0			31	1		61			91	•		121			151			181
2	2			32	1		62			92			122			152			182
	3			33			63			93			123			153			183
3	4			34]		64	1		94			124	,		154			184
4	(5)			35]		65			95			125			155			185
5	6			36	}		66			96			126			156			186
	7			37			67	1		97			127			157			187
6	8			38]		68	}		98			128			158			188
7	9			39	1		69]		99			129			159			189
8	10			40]		70			100			130			160			190
9	11			41]		71			101			131			161			191
10	(2)			42			72			102			132			162			192
11	(13)			43]		73			103			133			163			193
12	1			44			74			104			134			164			194
13	15			45			75			105			135			165			195
14	16			46]		76			106			136			166			196
	17			47			77			107			137			167			197
	18			48			78			108			138			168			198
	19			49			79			109			139			169			199
	20			50			80			110			140			170			200
	21			51			81			111			141			171			201
	22			52			82			112			142			172			202
	23			53			83]		113			143			173			203
	24	,		54			84			114			144			174			204
	25			55		L	85			115			145			175			205
	26			56			86	1		116			146			176			206
L	27			57			87			117			147			177			207
	28			58			88	1		118			148			178			208
	29			59			89			119			149			179			209
	30			60			90		-	120			150			180		1	210